

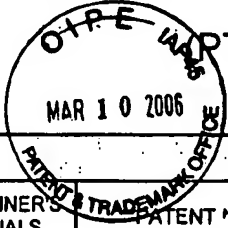


SHEET 1 OF 1

<b>LIST OF ART CITED BY APPLICANT</b>  <b>(PTO-1449)</b>				ATTY. DOCKET NO. <b>DPO-0009</b>		APPLN. SERIAL NO. <b>10/715,502</b>	
				APPLICANT(S) <b>Myung Dae OH</b>			
				FILING DATE <b>November 19, 2003</b>		GROUP <b>2661</b> <span style="float: right;">2154</span>	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE	
<b>U.S. PATENT APPLICATION PUBLICATIONS</b>							
	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS		
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	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS		
<b>FOREIGN PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
/M.K./	WO 00/49784	08/24/2000	WIPO	—	—	X	
/M.K./	EP 1 130 931	09/05/2001	Europe	—	—	X	
/M.K./	EP 1 111 872	06/27/2001	Europe	—	—	X	
/M.K./	WO 01/47206	06/28/2001	WIPO	—	—	X	
<b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)</b>							
/M.K./	ETSI TS 100 940; Digital Cellular Telecommunications System (Phase 2+); Mobile radio interface layer 3 specification; vol. 3-CN1, no. V7140, September 2001, XP014005790; section 6.1.3.1.1						
/M.K./	ETSI TS 101 351; Digital Cellular Telecommunications System (Phase 2+); General Packet Radio Service; Mobile Station-Serving GPRS Support Node; Logical Link Control layer specification; December 2000, XP014006203, section 6.4.1.6						
EXAMINER				DATE CONSIDERED			
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ATTY. DOCKET NO.  
DPO-0009APPLN. SERIAL NO.  
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APPLICANT(S)

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## U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	SUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE

## U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	

## U.S. PATENT APPLICATIONS

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

## FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
/M.K./	WO 01/39525	5/31/2001	WIPO	—	—	XX	
/M.K./	WO 02/085055	10/24/2002	WIPO	—	—	XX	
/M.K./	WO 02/15625	2/21/2002	WIPO	—	—	XX	
/M.K./	JP 2003-515995	5/7/2003	JAPAN(Full Japanese Text)	—	—	Abst. Only	
/M.K./	JP 2004-533160	10/28/2004	JAPAN(Full Japanese Text)	—	—	Abst. Only	
/M.K./	JP 2004506393	2/26/2004	JAPAN(Full Japanese Text)	—	—	Abst. Only	

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

/M.K./	Japanese Office Action

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